

Notice of References Cited	Application/Control No. 10/724,985	Applicant(s)/Patent Under Reexamination THEEL, WAYNE	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,341,084 B2	01-2002	Numata et al.	365/158
	C	US-6,246,630 B1	06-2001	Hosokawa et al.	365/230.06
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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